Substitute forms PTO/SB/08a & PTO/SB/08b	Application Number	10/701,950
	Filing Date	11-05-2003
INFORMATION DISCLOSURE	First Named Inventor	Elmer G. Fridrich
STATEMENT BY APPLICANT	Art Unit	2879
	Examiner Name	
Sheet 1 OF 1	Practitioner Docket No.	EF-101 E

U.S. PATENT DOCUMENTS

Exam.	Cite	Document Number	Publication Date	Name of Patentee or Applicant of	Relevant Pages, Columns, Lines
Initials	No.	NoKind Code (if known)	MM-DD-YYYY	Cited Document	-
Antt	Α	US-3,626,236	12-07-1971	Robinson et al.	
Anatt	В	US-3,894,227	07-08-1975	Pitkjaan et al.	
Antt	B 1	US-4,254,356	03-03-1981	Karikas	
Amt	B2	US-4,389,201	06-21-1983	Hansler et al.	
Amit	С	US-4,498,124	02-05-1985	Mayer et al.	
Antt	D	US-4,524,302	06-18-1985	Berlec	
Ant	E	US-4,580,199	04-01-1986	Wurster et al.	
Ant	F	US-4,719,545	01-12-1998	Cano	
Ant	G	US-4,727,449	02-23-1988	Fleck	
Annt	Н	US-4,810,932	03-07-1989	Ahlgren et al.	
Amit	Ī	US-5,088,012	02-11-1992	Burgess	
Amit	J	US-5,077,645	12-31-1991	Habinak	
Amth	K	US-5,138,228	08-11-1992	Thomas et al.	
Ant	L	US-5,146,134	09-08-1992	Stadler et al.	
Amt	M	US-5,239,231	08-24-1993	Grunder	
Amt	N	US-5,446,336	08-29-1995	Gleixner et al.	
Amil	0	US-5,896,004	04-20-1999	Feldman et al.	
Amit	P	US-5,440,457	08-08-1995	Meyer	
Amt	Q	US-5,896,007	04-20-1999	Dobiasch et al.	
Amit	R	US-5,984,490	11-16-1999	Leen	
Amt	S	US-6,133,676	10-17-2000	Chen	
Amt	T	US-6,211,616-B1	04-03-2001	Takeuti et al.	
Amt	U	US-6,367,949-B1	04-09-2002	Pederson	

FOREIGN PATENT DOCUMENTS

Exam Initia	. Cite	Foreign Patent Document Country Code-Number-Kind Code		Name of Patentee or Applicant of Cited Doc.	Relevant Pages, Columns, Lines	T
Amt	ΗV	WO98/14733	04-09-1998	Katougi et al.	Abstract, Figures	T

NON PATENT LITERATURE DOCUMENTS

Exam. Initials	Cite No.	Name of author (ALL-CAPS), title of article, title of item, date, pages, vol-issue #, publisher, city and/or country where published.	Т
Amt	W	where published. HAROLD WALLACE (Guest Editor for F.A. Furfari's "History" column), "A Different Kind of Chemistry: A History of Tungsten Halogen Lamps", IEEE Industry Applications Magazine, Vol. 7-#6 (Nov./Dec. 2001), IEEE, New York, NY. pgs. 10-17 (especially p. 16)	

Mwe M Signature